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10/781,040	02/18/2004	Dmitry Lubomirsky	008266/ECP/ECP/CKIM	8367	
44257 7590 08/28/2008 PATTERSON & SHERIDAN, LLP APPM/TX 3040 POST OAK BOULEVARD, SUITE 1500			EXAM	EXAMINER	
			VAN, LUAN V		
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Application No. Applicant(s) 10/781.040 LUBOMIRSKY ET AL. Office Action Summary Examiner Art Unit LUAN V. VAN 1795 -- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --Period for Reply A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS. WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION. Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status 1) Responsive to communication(s) filed on July 24, 2008. 2a) This action is FINAL. 2b) This action is non-final. 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213. Disposition of Claims 4) Claim(s) 1.2.4-6.8-10.12-16.19-24 and 26 is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration. 5) Claim(s) _____ is/are allowed. 6) Claim(s) 1,2,4-6,8-10,12-16,19-24 and 26 is/are rejected. 7) Claim(s) _____ is/are objected to. 8) Claim(s) _____ are subject to restriction and/or election requirement. Application Papers 9) The specification is objected to by the Examiner. 10) The drawing(s) filed on is/are; a) accepted or b) objected to by the Examiner. Applicant may not request that any objection to the drawing(s) be held in abevance. See 37 CFR 1.85(a). Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152. Priority under 35 U.S.C. § 119 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. Attachment(s) 1) Notice of References Cited (PTO-892) 4) Interview Summary (PTO-413) Paper No(s)/Mail Date. Notice of Draftsperson's Patent Drawing Review (PTO-948) 5) Notice of Informal Patent Application 3) Information Disclosure Statement(s) (PTO/SB/08)

Paper No(s)/Mail Date _

6) Other:

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DETAILED ACTION

Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on July 24, 2008 has been entered.

Response to Amendment

Applicant's amendment of July 24, 2008 does not render the application allowable.

Status of Objections and Rejections

The rejection of claim 3 and 25 is obviated by Applicant's cancellation.

All other rejections from the previous office action are maintained.

Claim Rejections - 35 USC § 112

The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

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Claims 1, 2, 4-6, 8-10, 12-16, 19-24, and 26 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the written description requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention.

Independent claims 1, 8, 15 and 23 recites performing the steps in the claims "sequentially" and that the "processing angle is different than the first angle and the second angle". These limitations are deemed to be new matter, because the specification does not support all the steps being preformed sequentially and that the processing angle is different than the first angle and the second angle.

Claim Rejections - 35 USC § 103

The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.

Claims 1, 2, 4, 8-9, 12-16, 20-24, and 26 are rejected under 35 U.S.C. 103(a) as being unpatentable over Dordi et al. '578 in view of Sendai et al.

Regarding claims 1 and 8, Dordi et al. '578 teach an electroplating method, comprising: loading a substrate into a receiving member (column 33 lines 33-47); tilting the receiving member to a first tilt angle measured from horizontal (column 34 lines 30-54); displacing the receiving member toward the fluid solution at the first tilt angle (i.e., a1, column 37, lines 35-58); tilting the receiving member to a second tilt angle (i.e., a2, column 37, lines 35-58) measured from horizontal when the substrate contacts the fluid

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solution, the second tilt angle being different from the first tilt angle; reducing the tilt angle to about horizontal (column 38 lines 41-44) and processing substrate at the horizontal processing angle. Dordi et al. also teach that the initial tilt angle is typically 45° and in some embodiment can approach 90° (column 38 lines 13-17).

Dordi et al. '578 differs from the instant claims in that the reference teaches positioning the substrate parallel to the surface of the anode in the horizontal position but does not explicitly disclose tilting the anode.

Sendai et al. teach an electroplating method wherein the tilt angle is greater than 0 degrees at a time when the substrate becomes completely immersed in the fluid solution (paragraph 25); the anode is tilted from horizontal at an angle of between about 1 and 10 degrees (paragraph 91); and the central axis of the substrate proximate is centered on the electrolyte solution (figures 11-12).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to have modified the method of Dordi et al. '578 by tilting the substrate and the anode to the processing angle of Sendai et al., because tilting the anode would prevent air bubbles from remaining on the surface to be plated and would enhance plating uniformity (paragraph 96 of Sendai et al.). Furthermore, since the first angle of Dordi et al. can be as large as 90° and the second angle is between 0-90° (column 38 lines 13-18 of Dordi et al.), it would have been obvious to one having ordinary skill in the art to have expected that the processing angle of Sendai et al. would be different than the first angle and the second angle because it is much smaller than the first angle and the second angle of Dordi et al.

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Addressing claims 21 and 22, it would have been obvious to one having ordinary skill in the art at the time the invention was made to recognize that the intermediate position of the substrate would be parallel to the surface of the anode when the anode is tilted at an angle as taught by Sendai et al. while the tilt angle of the substrate is reduced to horizontal as disclosed by Dordi et al. '578, since the tilt angle of the substrate would overlap the angle of the anode.

Regarding claims 2 and 12, Dordi et al. '578 teach an electroplating method wherein the first tilt angle is between about 0 and 90 degrees (column 35 lines 41-48), which encompasses the range of the instant claim.

Regarding claim 13, Dordi et al. '578 teach an electroplating method wherein the tilt angle is reduced to horizontal (column 38 lines 41-57).

Regarding claims 4 and 9, Dordi et al. '578 teach an electroplating method wherein the receiving member is rotated at a rotation rate of between about 0 rpm and about 200 rpm (column 38 lines 62-67).

Addressing claim 14, it would have been obvious to one having ordinary skill in the art at the time the invention was made to have modified the method of Dordi et al. '578 by tilting the substrate when the substrate is completely immersed in the fluid solution as taught by Sendai et al., because it would prevent air bubbles from remaining on the surface to be plated and prevent plating film defects.

Regarding claim 15, Dordi et al. '578 teach an electroplating method, comprising: positioning the substrate on a contact ring (column 33 lines 33-47); securing the substrate to the contact ring with a thrust plate assembly (column 33 lines 33-47); tilting

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the contact ring to a tilt angle of between 0 and 90 degrees (column 35 lines 41-48), which is within the range of the instant claim; vertically actuating the contact ring toward the plating electrolyte while maintaining the tilt angle (column 34 lines 55-64); rotating the contact ring at a rotation rate of between about 0 rpm and about 200 rpm (column 38 lines 62-67); reducing the tilt angle to a second angle (i.e., α 2, column 37, lines 35-58) when the contact ring initially touches the plating electrolyte; and positioning the substrate in a processing position (column 38 lines 41-57).

Dordi et al. '578 differs from the instant claims in that the reference teach positioning the substrate parallel to the surface of the anode in the horizontal position but does not explicitly disclose tilting the anode.

Sendai et al. teach an electroplating method wherein the tilt angle is greater than 0 degrees at a time when the substrate becomes completely immersed in the fluid solution (paragraph 25); the anode is tilted from horizontal at an angle of between about 1 and 10 degrees (paragraph 91); and the central axis of the substrate proximate is centered on the electrolyte solution (figures 11-12).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to have modified the method of Dordi et al. '578 by tilting the anode as taught by Sendai et al., because tilting the anode would prevent air bubbles from remaining on the surface to be plated and would enhance plating uniformity.

Regarding claim 16, Dordi et al. '578 teach an electroplating method wherein the second tilt angle is horizontal or about 0 degrees (column 38 lines 41-57).

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Addressing claim 20, it would have been obvious to one having ordinary skill in the art at the time the invention was made to have modified the method of Dordi et al. '578 by maintaining the central axis of the substrate proximately centered on the electrolyte solution as taught by Sendai et al., because it would enhance plating uniformity.

Regarding claim 23, Dordi et al. '578 teach an electroplating method, comprising: loading a substrate into a receiving member (column 33 lines 33-47); tilting the receiving member to a first tilt angle measured from horizontal (i.e., α 1, column 37, lines 35-58); immersing the substrate into the plating solution (column 34 lines 55-64); and pivoting the receiving member from the first angle to an intermediate position to a second angle (i.e., α 2, column 37, lines 35-58) while maintaining the substrate immersed in the plating solution (column 38 lines 24-26).

Dordi et al. '578 differs from the instant claims in that the reference teach positioning the substrate parallel to the surface of the anode in the horizontal position but does not explicitly disclose tilting the substrate to a third angle.

Sendai et al. teach an electroplating method wherein the tilt angle is greater than 0 degrees at a time when the substrate becomes completely immersed in the fluid solution (paragraph 25); the anode is tilted from horizontal at an angle of between about 1 and 10 degrees (paragraph 91); and the central axis of the substrate proximate is centered on the electrolyte solution (figures 11-12).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to have modified the method of Dordi et al. '578 by tilting the

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substrate to a third angle as taught by Sendai et al., because tilting the substrate would prevent air bubbles from remaining on the surface to be plated, thus enhancing plating uniformity. It would have been obvious to one having ordinary skill in the art at the time the invention was made to recognize that the intermediate position of the substrate would be parallel to the surface of the anode when the anode is tilted at an angle as taught by Sendai et al. while the tilt angle of the substrate is reduced to horizontal as disclosed by Dordi et al. '578, since the tilt angle of the substrate would overlap the angle of the anode.

Addressing claim 24, it would have been obvious to one having ordinary skill in the art at the time the invention was made to have modified the method of Dordi et al. '578 by tilting the anode as taught by Sendai et al., because tilting the anode would prevent air bubbles from remaining on the surface to be plated and would enhance plating uniformity.

Regarding claim 26, Dordi et al. '578 vertically displacing the substrate while the substrate is immersing inside the plating solution (column 39 lines 12-16).

Claims 5, 6, 10 and 19 are rejected under 35 U.S.C. 103(a) as being unpatentable over Dordi et al. '578 in view of Sendai et al., and further in view of Wang et al.

Dordi et al. '578 and Sendai et al. teach the method as described above. The difference between the reference to Dordi et al. '578 and the instant claims is that the reference does not explicitly teach oscillating the substrate.

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Wang et al. teach that it is desirable "to vibrate the substrate, e.g., substantially vertically and/or horizontal [sic], relative to the electrolyte solution" (paragraph 81) in order to "enhance the fluid flow of the electrolyte solution into the features contained on the plating surfaces."

It would have been obvious to one having ordinary skill in the art at the time the invention was made to have modified the method of Dordi et al. '578 and Sendai et al. by vibrating or oscillating the substrate as taught by Wang et al., because it would enhance the fluid flow of the electrolyte solution into the features contained on the plating surfaces, and because it would enhance the metal film deposition rate within the features.

Response to Arguments

Applicants' arguments have been considered but are moot in view of the new ground(s) of rejection.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Luan V. Van whose telephone number is 571-272-8521. The examiner can normally be reached on M-F 9:30-6:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nam Nguyen can be reached on 571-272-1342. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

LVV August 22, 2008

/Edna Wong/

Primary Examiner, Art Unit 1795